

Vishay Siliconix

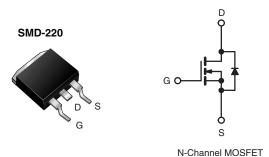
RoHS*

COMPLIANT HALOGEN

FREE

Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	200				
R _{DS(on)} (Ω)	V _{GS} = 5 V 0.18				
Q _g (Max.) (nC)	66				
Q _{gs} (nC)	9.0				
Q _{gd} (nC)	38				
Configuration	Single				



FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Logic-Level Gate Drive
- $R_{DS(on)}$ Specified at $V_{GS} = 4 V$ and 5 V
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SMD-220 is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The SMD-220 is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application.

ORDERING INFORMATION						
Package	SMD-220	SMD-220	SMD-220			
Lead (Pb)-free and Halogen-free	SiHL640S-GE3	SiHL640STRL-GE3 ^a	SiHL640STRR-GE3 ^a			
Load (Dh) froe	IRL640SPbF	IRL640STRLPbFa	IRL640STRRPbFa			
Lead (Pb)-free	SiHL640S-E3	SiHL640STL-E3a	SiHL640STR-E3a			

See device orientation.

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	LIMIT	UNIT				
Drain-Source Voltage			V_{DS}	200	V		
Gate-Source Voltage			V_{GS}	± 10	7 v		
Continuous Drain Current	V _{GS} at 5.0 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	1	17			
Continuous Drain Current	VGS at 3.0 V	T _C = 100 °C	I _D	11	Α		
Pulsed Drain Current ^a			I _{DM}	68			
Linear Derating Factor				1.0	W/°C		
Linear Derating Factor (PCB Mount)e			0.025	- VV/ C			
Single Pulse Avalanche Energy ^b			E _{AS}	580	mJ		
Repetitive Avalanche Currenta			I _{AR}	10	Α		
Repetitive Avalanche Energy ^a			E _{AR}	13	mJ		
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P _D	125	w		
Maximum Power Dissipation (PCB Mount)e T _A = 25 °C				3.1	l vv		
Peak Diode Recovery dV/dt ^c			dV/dt	5.0	V/ns		
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C		
Soldering Temperature for 10 s				300 ^d]		

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 3.0 \,\text{mH}$, $R_g = 25 \,\Omega$, $I_{AS} = 17 \,\text{A}$ (see fig. 12). c. $I_{SD} \le 17 \,\text{A}$, $I_{AS} = 150 \,^{\circ}\text{C}$.

- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 Material).

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRL640S, SiHL640S

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THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	-	62		
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-	-	40	°C/W	
Maximum Junction-to-Case (Drain)	R_{thJC}	-	-	1.0		

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$, $I_D = 250 \mu A$		200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.27	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	· V _{GS} , I _D = 250 μA	1.0	-	2.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 10 V	-	-	± 100	nA
Zoro Coto Voltago Drain Current		V _{DS} =	200 V, V _{GS} = 0 V	-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 160 V	', V _{GS} = 0 V, T _J = 125 °C	-	-	250	μA
Duain Cauras On State Besistance	П	V _{GS} = 5.0 V	I _D = 10 A ^b	-	-	0.18	0
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.0 V	I _D = 8.5 A ^b	-	-	0.27	Ω
Forward Transconductance	9fs	V _{DS} =	= 50 V, I _D = 10 A ^b	16	-	-	S
Dynamic		•					
Input Capacitance	C _{iss}		$V_{GS} = 0 V$	-	1800	-	pF
Output Capacitance	C _{oss}]	$V_{DS} = 25 \text{ V},$	-	400	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	120	-	
Total Gate Charge	Q_g			-	-	66	
Gate-Source Charge	Q_{gs}	$V_{GS} = 5.0 \text{ V}$	$I_D = 17 \text{ A}, V_{DS} = 160 \text{ V},$ see fig. 6 and 13^b	-	-	9.0	nC
Gate-Drain Charge	Q_{gd}			-	-	38	
Turn-On Delay Time	t _{d(on)}	V_{DD} = 100 V, I_{D} = 17 A, R_{g} = 4.6 $Ω$, R_{D} = 5.7 $Ω$, see fig. 10 ^b		-	8.0	-	ns
Rise Time	t _r			-	83	-	
Turn-Off Delay Time	t _{d(off)}			-	44	-	
Fall Time	t _f			-	52	-	
Internal Drain Inductance	L_D	Between lead 6 mm (0.25") f	rom	-	4.5	-	ъЦ
Internal Source Inductance	L _S	package and center of die contact		-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	17	А
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	68	^
Body Diode Voltage	V_{SD}	T _J = 25 °C	I_{S} , I_{S} = 17 A, V_{GS} = 0 V^{b}	_	-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	T 25 °C I-	= 17 A, dl/dt = 100 A/µs ^b	_	310	470	ns
Body Diode Reverse Recovery Charge	Q_{rr}	1 J = 25 C, IF	- 17 A, ul/ul = 100 A/µS	-	3.2	4.8	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	-on is dor	ninated b	y L _S and	L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

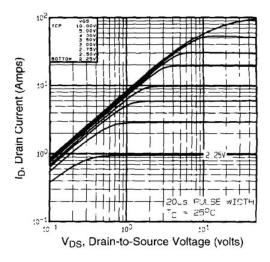


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

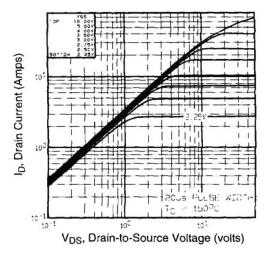


Fig. 2 - Typical Output Characteristics, $T_C = 150 \, ^{\circ}\text{C}$

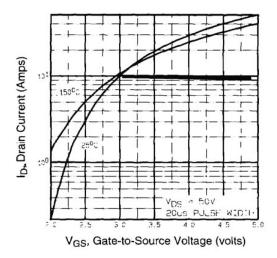


Fig. 3 - Typical Transfer Characteristics

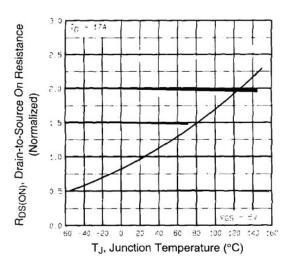


Fig. 4 - Normalized On-Resistance vs. Temperature

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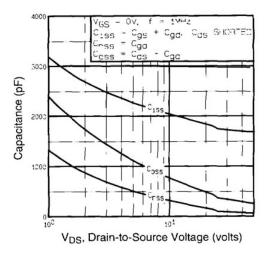


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

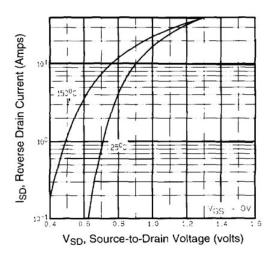


Fig. 7 - Typical Source-Drain Diode Forward Voltage

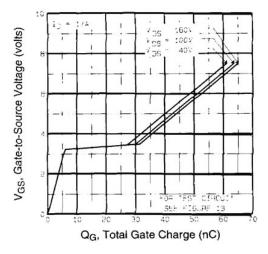


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

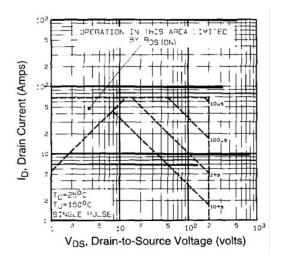


Fig. 8 - Maximum Safe Operating Area



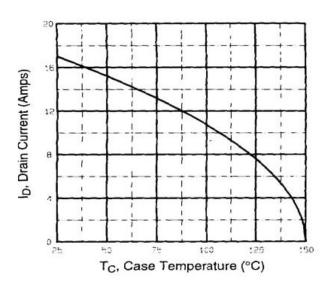


Fig. 9 - Maximum Drain Current vs. Case Temperature

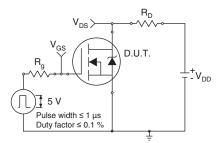


Fig. 10a - Switching Time Test Circuit

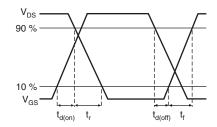


Fig. 10b - Switching Time Waveforms

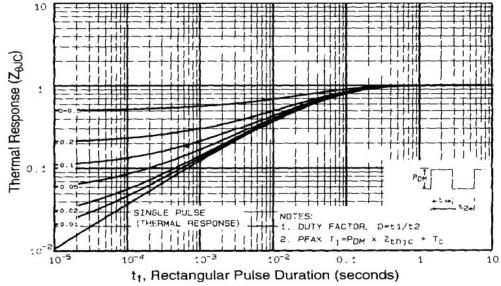


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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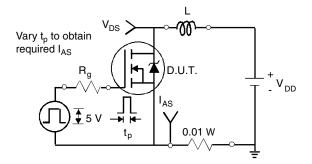


Fig. 12a - Unclamped Inductive Test Circuit

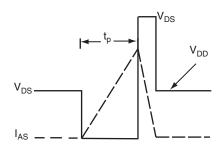


Fig. 12b - Unclamped Inductive Waveforms

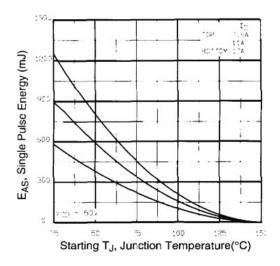


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

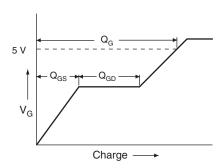


Fig. 13a - Basic Gate Charge Waveform

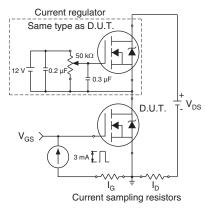
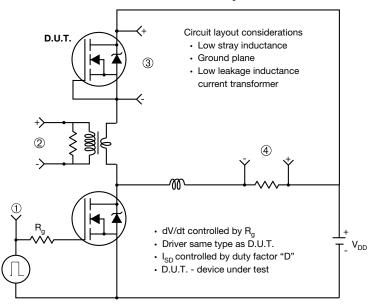


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



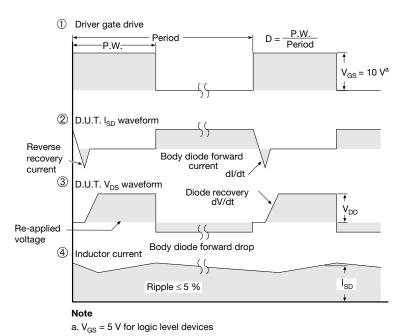


Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91306.





TO-263AB (HIGH VOLTAGE)







]	+		D1	4
	-E1-	₩	<u> </u>	7

	MILLIN	METERS	INC	HES
DIM.	MIN. MAX.		MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380

	MILLIN	METERS	INC	HES	
DIM.	MIN. MAX.		MIN.	MAX.	
D1	6.86	-	0.270	-	
E	9.65	10.67	0.380	0.420	
E1	6.22	-	0.245	i	
е	2.54	BSC	0.100 BSC		
Н	14.61	15.88	0.575	0.625	
L	1.78	2.79	0.070	0.110	
L1	-	1.65	ı	0.066	
L2	-	1.78	i	0.070	
L3	0.25 BSC		0.010	BSC	
L4	4.78	5.28	0.188	0.208	

DWG: 5970 Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).

ECN: S-82110-Rev. A, 15-Sep-08

- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.

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